Searcn	notes

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/712,687	MIWA, AKIHIRO	
Examiner	Art Unit	
Jianchun Oin	2837	

SEARCHED					
Class	Subclass	Oate	Examiner		
84	600,615, 645		FO		
	470,477R				
345	157				
715 .	856	7/6/2005	)  -  -		
Above	updated updated upd	2/13/06	50		
Above	updated	7/5/56	J6		
Above	upd	3/14/5	JO		
	•	,			
<u>.</u>					
	()				

INTERFERENCE SEARCHED				
Subclass	Date	Examine		
	Υ	T		

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EAST Text Search	7/06/05	76
EAST text Search updated	थ्राइ/स	TO
EAST text Search updated	7/5/06	TQ
EAST text Search upd.	3/14/27	JQ